

<b>Notice of References Cited</b>	Application/Control No. 10/564,463		Applicant(s)/Patent Under Reexamination DE LEEUW, VICTOR	
	Examiner STEPHEN HEPPERLE		Art Unit 3753	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,445,532	05-1984	Mitchell, John D.	137/495
*	B	US-5,406,975	04-1995	Nakamichi et al.	137/495
*	C	US-6,199,582	03-2001	Matsuzawa et al.	137/503
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.